Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = -50$ V, starting $T_J = 25$ °C, L = 8.2 mH, $R_G = 25 \Omega$, $I_{AS} = -12$ A (see fig. 12). c. $I_{SD} \leq -12$ A, dI/dt ≤ 150 A/µs, $V_{DD} \leq V_{DS}$, $T_J \leq 150$ °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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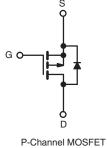
RoHS

COMPLIANT

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	- 200 V				
R _{DS(on)} (Max.) (Ω)	V _{GS} = - 10 V	0.50			
Q _g (Max.) (nC)	44				
Q _{gs} (nC)	7.1				
Q _{gd} (nC)	27				
Configuration	Single				

TO-247



FEATURES

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- P-Channel
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- · Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole. It also provides greater creepage distance between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION	
Package	TO-247
Lead (Pb)-free	IRFP9240PbF
	SiHFP9240-E3
SnPb	IRFP9240
	SiHFP9240

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	- 200	v	
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	Voc at - 10 V	tt - 10 V $\frac{T_C = 25 \degree C}{T_C = 100 \degree C}$	I _D	- 12		
	VGS at - 10 V			- 7.5	А	
Pulsed Drain Current ^a			I _{DM}	- 48		
Linear Derating Factor				1.2	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	790	mJ	
Repetitive Avalanche Current ^a			I _{AR}	- 12	А	
Repetitive Avalanche Energy ^a			E _{AR}	15	mJ	
Maximum Power Dissipation	T _C = 25 °C		PD	150	W	
Peak Diode Recovery dV/dt ^c			dV/dt	- 5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature)	for 1	10 s		300 ^d		
Mounting Torque	6 22 or N	6-32 or M3 screw		10	lbf ⋅ in	
	0-52 OF INIS SCIEW			1.1	N ⋅ m	





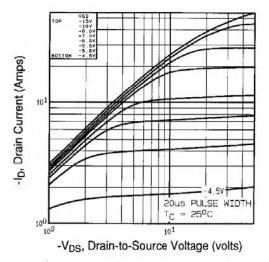


THERMAL RESISTANCE RA	TINGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	- 40 0.24 -						
Case-to-Sink, Flat, Greased Surface	R _{thCS}				°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.83						
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,	unless otherv	vise noted						
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static								
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	0 V, $I_D = -$	250 μΑ	- 200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I	l _D = - 1 mA	-	- 0.20	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = 1$	V_{GS} , $I_D = -$	250 μΑ	- 2.0	-	- 4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V			-	-	± 100	nA
Zara Gata Valtaga Drain Current	I	$V_{DS} = -200 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	- 100	μA	
Zero Gate Voltage Drain Current	I _{DSS}	V_{DS} = - 160 V, V_{GS} = 0 V, T_{J} = 125 °C			-	-		- 500
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D =	= - 7.2 A ^b	-	-	0.50	Ω
Forward Transconductance	g _{fs}	V _{DS} =	- 50 V, I _D =	- 7.2 A	4.2	-	-	S
Dynamic								
Input Capacitance	C _{iss}		V _{GS} = 0 V,		-	1200	-	
Output Capacitance	C _{oss}	$V_{DS} = -25 V,$ f = 1.0 MHz, see fig. 5		-	370	-	pF	
Reverse Transfer Capacitance	C _{rss}			-	81	-		
Total Gate Charge	Qg			A, V _{DS} = - 160 V g. 6 and 13 ^b	-	-	44	nC
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V			-	-	7.1	
Gate-Drain Charge	Q _{gd}				-	-	27	
Turn-On Delay Time	t _{d(on)}				-	14	-	
Rise Time	t _r	V_{DD} = - 100 V, I _D = - 11 A R _G = 9.1 Ω, R _D = 8.6 Ω, see fig. 10 ^b		-	43	-	ns	
Turn-Off Delay Time	t _{d(off)}			-	39	-		
Fall Time	t _f	-	-		-	38	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	- nH	
Internal Source Inductance	L _S			-	13	-		
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	- 12	A	
Pulsed Diode Forward Current ^a	I _{SM}	p - n junction diode			-	-		- 48
Body Diode Voltage	V_{SD}	$T_{J} = 25 \ ^{\circ}\text{C}, \ I_{S} = -12 \ \text{A}, \ V_{GS} = 0 \ V^{b}$			-	-	- 5.0	V
Body Diode Reverse Recovery Time	t _{rr}	- $T_J = 25 \text{ °C}, I_F = -11 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}^b$		-	250	300	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.9	3.6	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated				ninated by	y L _S and L	_D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



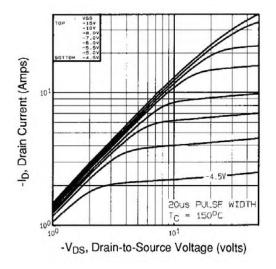


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

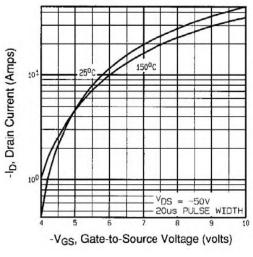


Fig. 3 - Typical Transfer Characteristics

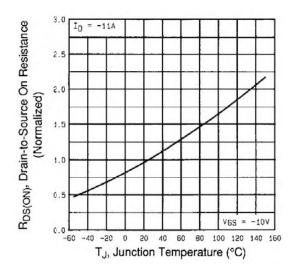


Fig. 4 - Normalized On-Resistance vs. Temperature

IRFP9240, SiHFP9240

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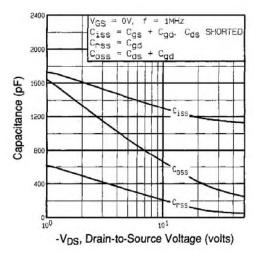


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

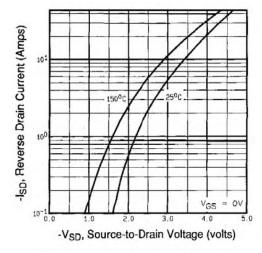


Fig. 7 - Typical Source-Drain Diode Forward Voltage

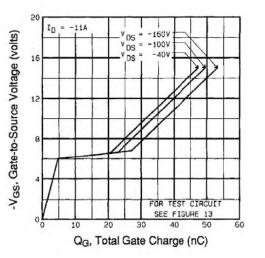


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

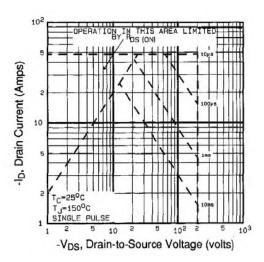


Fig. 8 - Maximum Safe Operating Area



IRFP9240, SiHFP9240

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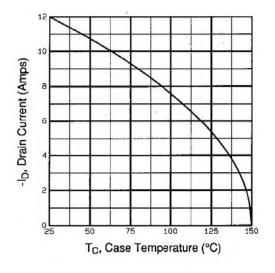


Fig. 9 - Maximum Drain Current vs. Case Temperature

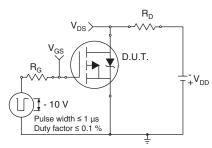


Fig. 10a - Switching Time Test Circuit

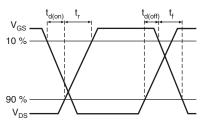


Fig. 10b - Switching Time Waveforms

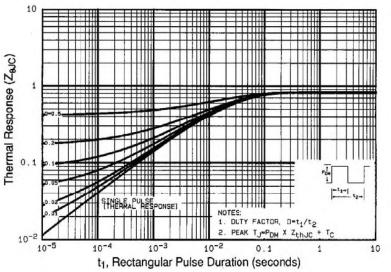


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

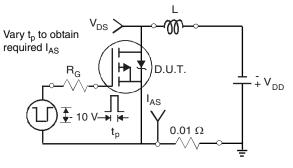
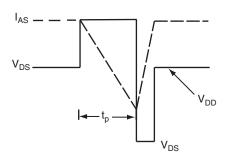


Fig. 12a - Unclamped Inductive Test Circuit



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Fig. 12b - Unclamped Inductive Waveforms

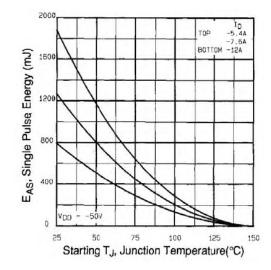


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

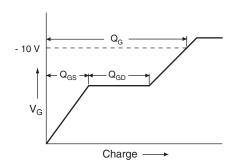
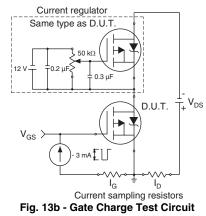
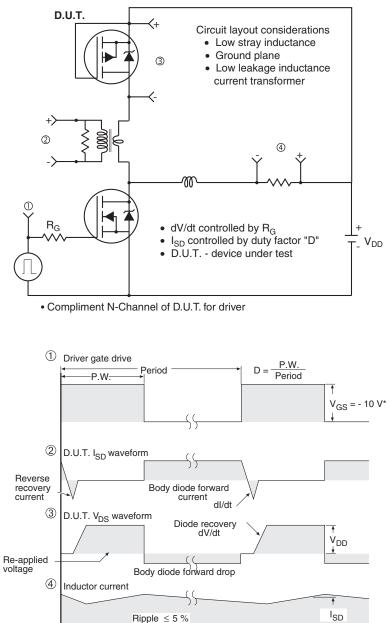


Fig. 13a - Basic Gate Charge Waveform

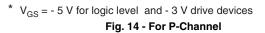


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Peak Diode Recovery dV/dt Test Circuit



Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <u>www.vishay.com/ppg?91239</u>.



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